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# Elaboration and dielectric study of ferroelectric or relaxor ceramics in the ternary system BaTiO<sub>3</sub>-NaNbO<sub>3</sub>-BaSnO<sub>3</sub>

Abdelhedi Aydi<sup>a,\*</sup>, Annie Simon<sup>b</sup>, Dominique Michau<sup>b</sup>, Régnault Von Der Mühll<sup>b</sup>, Najmeddine Abdelmoula<sup>a</sup>, Hamadi Khemakhem<sup>a</sup>

<sup>a</sup> Laboratoire des Matériaux Ferroélectriques, Faculté des Sciences de Sfax, 3018 Sfax, Tunisia <sup>b</sup> CNRS, Université de Bordeaux, ICMCB, 87 Avenue Dr A. Schweitzer, F-33608 Pessac, France

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## 1. Introduction

Stannates with the general formula  $MSnO_3$ , where M = Ca, Sr or Ba, are dielectric materials that can be used as thermally stable capacitors [1–4].

Sodium niobate NaNbO<sub>3</sub> is a dielectric material with a perovskite type structure. At room temperature, it crystallizes with orthorhombic symmetry (Pbma), shows antiferroelectric behavior, and becomes ferroelectric at high temperature (Curie temperature  $T_{\rm C}$  = 360 °C) [5].

BaTiO<sub>3</sub> is an ABO<sub>3</sub> perovskite type with displacive ferroelectric properties. The substitution in the Ba or Ti sites with other ions or cations leads to remarkable changes in various characteristics [6,7].

In relaxor ferroelectric, there is an increase of  $T_{\rm m}$  and a decrease of the real part of permittivity ( $\varepsilon'_r$ ) with increasing frequency, where  $T_{\rm m}$  is the temperature of the maximum dielectric permittivity. One broad peak with frequency dispersion takes place in real and imaginary parts of the maximum permittivity.

\* Corresponding author.

*E-mail addresses*: aydi\_abdelhedi@yahoo.fr (A. Aydi), simon@icmcb-bordeaux.cnrs.fr (A. Simon).

#### ABSTRACT

The present work reports the elaboration and physical investigation of new compounds of the following composition  $Ba_{1-x}Na_x(Ti_{1-y}Sn_y)_{1-x}Nb_xO_3$  (BTSnNxy). The studied ternary system presents some continuous solid solutions between the next 3 phases: the NaNbO<sub>3</sub> antiferroelectric phase that becomes easily ferroelectric at low rate substitutions, the BaTiO<sub>3</sub> ferroelectric phase and the paraelectric stannate phase BaSnO<sub>3</sub>. Two different dielectric behaviors can be observed once some substitutions are made either in A or B sites of an ABO<sub>3</sub> perovskite. These substitutions modify the dielectric properties of the material. The introduction of Sn<sup>4+</sup> and Ti<sup>4+</sup> cations in the B site favors, respectively, a decrease of the transition temperature and an increase in the value of the real dielectric permittivity. The transition temperature should be modulated by varying the rate of cationic substitution. Some relaxor materials can be obtained at a temperature around room temperature.

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In the prototypical relaxor PMN (PbMg<sub>1/3</sub>Nb<sub>2/3</sub>), the disordered distribution of cations in the B site plays an important role in the classical non-relaxor–relaxor transition just like BTZ system [8–10]. The origin of the relaxor phenomenon is a dynamic polar cluster created by a disordered distribution of A and B site substitutions [11–15].

In the binary oxide system [xNaNbO<sub>3</sub> + (1 – x)BaSnO<sub>3</sub>], singlephase perovskite compounds have already been obtained. When the composition x increases, the values of  $T_m$ , the dielectric permittivity at  $T_m$ , and  $\varepsilon'_{rmax}$  increase significantly [16,17].

Therefore, it is of great interest to investigate the correlation between substitution effect in the A and B sites and the role played by the introduction of Sn atoms on the modification of the chemical bonding in order to explain the dielectric properties of the solid solution BTSnNxy.

Developed were new ferroelectric or relaxor compounds  $(Ba_{1-x}Na_x(Ti_{1-y}Sn_y)_{1-x}Nb_xO_3)$  with high permittivity close to 300 K.

#### 2. Experimental details

BTSnNxy ceramic samples with composition ( $0.60 \le x$  and  $y \le 0.75$ ) were elaborated by solid state reaction at 1030 °C for 15 h under an oxygenic atmosphere, using BaCO<sub>3</sub>, Na<sub>2</sub>CO<sub>3</sub>, TiO<sub>2</sub>, SnO<sub>2</sub>, and Nb<sub>2</sub>O<sub>5</sub> powders in stoichiometric amounts.

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**Fig. 1.** (a) X-ray diffraction pattern of a BTSnNxy powder with composition corresponding to x = 0.80 and y = 0.20. (b) X-ray diffraction pattern of a BTSnNxy powder with composition corresponding to x = 0.825 and y = 0.10.

Powders were pressed under 100 MPa into disks of 8 mm in diameter and about 1 mm in thickness. Calcination at 1030 °C for 15 h was followed by 2 h of sintering at 1250 °C for  $0.60 \le x$  and  $y \le 0.75$ . The diameter shrinkage,  $\Delta \Phi / \Phi = (\Phi_{init} - \Phi_{end})/\Phi_{init}$ , and the compactness (experimental density/theoretical density) were determined. Their average values were 12–15% and 92–94%, respectively, depending on the composition.

At room temperature, the powder was analyzed by X-ray diffraction patterns by means of a Philips Diffractometer, using the CuK $\alpha$  radiation, the angular range  $10^\circ \leq 2\theta \leq 110^\circ$ , and a 10 s interval for each step of 0.02°. This allows to determine the symmetry and the limits of the solid solution region at room temperature.

Dielectric measurements were performed on sintered ceramic disks (6.5 mm diameter and 1 mm thickness) after deposition of gold electrodes (600 nm min<sup>-1</sup> for 10 min) on the circular faces by cathodic sputtering. The real and imaginary parts of relative permittivity  $\varepsilon'_r$  and  $\varepsilon''_r$  were determined under a Helium atmosphere as a function of both temperature (80–600 K) and frequency (10<sup>2</sup>–2.10<sup>6</sup> Hz) using a Wayne-Kerr 6425 frequency analyzer.

Piezoelectric measurements were performed at 300 K using an impedance analyser (HP 4194 A).

A scanning microscope (SEM), JEOL 6360A, was used to characterize the microstructure.

The Raman spectra were recorded on a Horiba Lab-ram HR 800 instrument using the 633 nm exciting light of argon laser.

#### 3. Results and discussion

The XRD patterns of BTSnNxy ( $0.60 \le x$  and  $y \le 0.75$ ) result in either a tetragonal or cubic structure at room temperature for all compounds. For example, patterns of BTSnNxy (x = 0.80 y = 0.20, and x = 0.825 y = 0.10) ceramics are shown in Fig. 1(a) and 1(b), respectively. The results reveal a single perovskite phase indicating that



**Fig. 2.** SEM picture of the surface of a BTSnNxy ceramic (x = 0.90 and y = 0.75).

Ti<sup>4+</sup> diffuses into the B-site of  $Ba_{1-x}Na_x[Sn_{1-x}Nb_x]O_3$ . The unit cell and profile parameters were determined using a global profilematching method with the software "fullprof" [18]. The estimated value of unit cell parameters *a*, *c* and volume *V* are given in Table 1 of BTSnNxy (x = 0.60, 0.70, 0.80, 0.825, 0.90 and y = 0.10, 0.20, 0.525,0.75). The symmetry of the ceramic specimens appears to be cubic with space group *Pm3m* or tetragonal *P4mm*. The decrease in the lattice parameters when *x* increases and *y* decreases can be due to the values of ionic radii *r* (Na<sup>+</sup> = 1.18 Å) and *r* (Nb<sup>5+</sup> = 0.64 Å) for NaNbO<sub>3</sub> quite lower than those of *r* (Ba<sup>2+</sup> = 1.61 Å), *r* (Sn<sup>4+</sup> = 0.69 Å) and *r* (Ti<sup>4+</sup> = 61 Å) for Ba(Sn,Ti)O<sub>3</sub>.

The SEM micrograph of BTSnN (x = 0.9, y = 0.75) ceramic is shown in Fig. 2. All samples were sintered at 1250 °C for 2 h. A well-dense ceramic is obtained with an average grain size of the order of 2 µm for all compounds BTSnN (x = 0.60, 0.70, 0.80, 0.825, 0.90 and y = 0.10, 0.20, 0.525, 0.75).

The temperature dependence of the real  $\varepsilon'_r$  and imaginary  $\varepsilon''_r$  parts of the permittivity in the frequency range 0.1–200 kHz for BTSnNxy is shown in Fig. 3. As examples, classical ferroelectric (Fig. 3(a)), relaxor (Fig. 3(b)), relaxor at  $T_m$  near 300 K (Fig. 3(c)) and the imaginary part of the permittivity (Fig. 3(d)) are noted. Three anomalies are observed on heating, for compositions close to BaTiO<sub>3</sub>, i.e. the solid solution BTSnNxy (x = 0.90, y = 0.10). These anomalies are related to phase transitions: trigonal-orthorhombic at  $T_2$ , orthorhombic-tetragonal at  $T_1$  and tetragonal-cubic at  $T_C$ . The values of  $T_C = 468$  K,  $T_1 = 240$  K and  $T_2 = 320$  K, were independent from frequency. For BaTiO<sub>3</sub>, these temperatures have been observed at  $T_C = 393$  K,  $T_1 = 268$  K and  $T_2 = 183$  K [19,20]. For the relaxor compounds like BTSnNxy (x = 0.60, y = 0.10), we only observe the relaxor/paraelectric transition at  $T_m$ .  $T_m$  is near 300 K for some compositions (BTSnNxy:  $x \ge 0.80$ ,  $y \le 0.20$ ).

Depending on the composition, two types of behavior appear: classical ferroelectric or relaxor. Fig. 4 shows the ternary diagram BaTiO<sub>3</sub>–NaNbO<sub>3</sub>–BaSnO<sub>3</sub>. When the rate y of Sn<sup>4+</sup> substitution increases,  $T_{\rm C}$  (tetragonal-cubic) decreases strongly (Fig. 5) as for the BSnNO.9 solid solution [16]. When the Ti<sup>4+</sup> ratio increases,  $\varepsilon'_{\rm rmax}$ increases exponentially (Fig. 6).

The admittance and susceptance of a sintered cylindrical ceramic disk (6.5 mm in diameter and 0.6 mm thickness) with composition BTSnNxy (x=0.825, y=0.10) were measured versus frequency around the main transverse resonance mode. The ceramic is polarized under continuous field of 1.6 kV at 300 K for 15 min. The variation of the admittance (G) and the susceptance (B) versus frequency is reported in Fig. 7. The calculation of the transverse piezoelectric coefficient at room temperature gives  $d_{31}$  = -1.695 pC/N.

Table 1
Refined unit cell parameters for BTSnNxy ceramics (x = 0.60, 0.70, 0.80, 0.825, 0.90 and y = 0.10, 0.20, 0.525, 0.75

x	<i>y</i> = 0.1			<i>y</i> = 0.2			<i>y</i> = 0.525			<i>y</i> = 0.75		
	a (Å)	c (Å)	$V(Å^3)$	a (Å)	c (Å)	$V(Å^3)$	a (Å)	c (Å)	$V(Å^3)$	a (Å)	c (Å)	$V(Å^3)$
0.6	3.978		62.949	4.031		65.499	4.052		66.528			
0.7	3.965		62.334	4.022		65.061	4.041		65.988	4.054		66.627
0.8	3.957		61.958	4.01		64.481	4.033		65.597	4.042		66.037
0.825	3.954	3.968	62.036	4.008	4.018	64.545	4.031	4.044	65.710			
0.9	3.948	3.971	61.894	4.000	4.024	64.384	4.028	4.035	65.467	4.039	4.042	65.939



**Fig. 3.** (a) Thermal variation of permittivity  $e'_r$  for a ceramic sample BTSnNxy with composition corresponding to x = 0.90 and y = 0.10. (b) Thermal variation of permittivity  $e'_r$  for a ceramic sample BTSnNxy with composition corresponding to x = 0.60 and y = 0.10. (c) Thermal variation of permittivity  $e'_r$  for a ceramic sample BTSnNxy with composition corresponding to x = 0.80 and y = 0.20. (d) Thermal variation of permittivity  $e''_r$  for a ceramic sample BTSnNxy with composition corresponding to x = 0.80 and y = 0.20. (d) Thermal variation of permittivity  $e''_r$  for a ceramic sample BTSnNxy with composition corresponding to x = 0.80 and y = 0.20.



Fig. 4. Relaxor and ferroelectric phases in the ternary diagram  ${\rm BaTiO_3-NaNbO_3-BaSnO_3.}$ 

Fig. 8 depicts the room temperature spectra for 4 compositions of the solid solutions BTSnNxy (x=0.8, y=0.1), (x=0.90, y=0.20), (x=0.7, y=0.5) and (x=0.85, y=0.75) (in the wave number range 50–1500 cm<sup>-1</sup>). Raman spectra show vibration bands which weaken and broaden with increasing content of BaTiO<sub>3</sub> due to the presence of disorder in the cubic phase [21]. This disorder stems



**Fig. 5.** Variation of  $T_{\rm C}$  or  $T_{\rm m}$  vs. composition for BTSnNxy ceramics.



**Fig. 6.** Variation of  $\varepsilon'_{\text{rmax}}$  (1 kHz) vs. composition for BTSnNxy ceramics.



**Fig. 7.** Variation of the admittance (*G*) and the susceptance (*B*) as functions of frequency at T = 300 K for BTSnNxy ceramic with x = 0.825 and y = 0.10.

from the displacement of Sn/Ti/Nb cations along the cubic diagonals [22]. These modes appear at frequencies close to those of BaTiO<sub>3</sub> and NaNbO<sub>3</sub> [23].

The cubic perovskite structure with  $O_h$  symmetry above  $T_C$  distorts into a tetragonal structure  $C_{4V}$  [24,25]. Using a standard group theory analysis, normal optic modes can be shown to belong to the  $3T_{1u} \oplus T_{2u}$  irreducible representations of the point group  $O_h$ . When entering the tetragonal  $C_{4v}$  symmetry, the IR active  $T_{1u}$  modes are expected to split into  $A_1 \oplus E$ , and the silent mode  $T_{2u}$  into  $B_1 \oplus E$  [26,27]. The peak attributed to the Nb–O phonon is observed in Raman spectrum at 203 and 553 cm<sup>-1</sup> for BTSnNxy (x=0.80,



**Fig. 8.** Raman spectra of BTSnNxy ((*y* = 0.1, *x* = 0.8), (*y* = 0.20, *x* = 0.90), (*y* = 0.5, *x* = 0.7) and (*x* = 0.85, *y* = 0.75)) ceramics at room temperature.

y=0.10), at 313 and 807 cm<sup>-1</sup> for BTSnNxy (x=0.90, y=0.20), at 205 and 563 cm<sup>-1</sup> for BTSnNxy (x=0.70, y=0.50) and at 236 and 614 cm<sup>-1</sup> for BTSnNxy (x=0.85, y=0.75). The peak attributed to Sn–O is observed at 824, 842, 876 and 1160 cm<sup>-1</sup> for BTSnNxy (x=0.8, y=0.1), (x=0.7, y=0.5), (x=0.85, y=0.75) and (x=0.90, y=0.20), respectively. All the bands were accompanied by a significant broadening, a weaker intensity and a shift toward the high frequencies. The dynamic of the structure was studied by analyzing the characteristic modes associated with nano-regions in relaxors. This deduction is based on the fact that local symmetry of nano-regions is different from that of the global symmetry.

#### 4. Conclusions

New BTSnNxy ceramics have been elaborated by a solidstate technique. The dielectric permittivity was systematically studied. Structural and piezoelectric measurements and Raman spectroscopy analysis were carried out on selected compositions to complement the understanding of the materials' behavior. The results of XRD show that Ti<sup>4+</sup> diffuses into the Ba<sub>1-x</sub>Na<sub>x</sub>Sn<sub>1-</sub>xNbxO<sub>3</sub> (BSnNx) lattice to form a solid solution with a perovskite type phase of the composition Ba<sub>1-x</sub>Na<sub>x</sub>(Ti<sub>1-y</sub>Sn<sub>y</sub>)<sub>1-x</sub>Nb<sub>x</sub>O<sub>3</sub> (BTSnNxy) in the range 0.60 ≤ x and y ≤ 0.75.

Dielectric measurements show two kinds of behavior depending on the composition: classical ferroelectric or relaxor types. The relaxor effect is due to a modification of the chemical bonding that results in the substitution of Ti for Sn. As it has been already reported, the screen effect due to internal *d* electrons of Sn atoms decreases the polarization coupling in the ferroelectric lattice. Thus, the disorder is between Sn and Ti.

The studies of the dielectric properties of the composition show that in the NaNbO<sub>3</sub>–MSnO<sub>3</sub> (M = Ba, Ca) solid solutions, the origin of the relaxor effect is due to the introduction of  $Sn^{4+}$  in octahedral site.

For low NaNbO<sub>3</sub> substitution rates, the crystalline network has Nb–O bonds in which the covalent character allows long-distance cooperative interactions that involve the ferroelectric character.

The increase in the amount of Tin in the network causes many ionic Sn–O links. They break the cooperative effect of Nb–O bonds. It appears nano-domains of Nb–O clusters, isolated from one another by Sn–O links which give the relaxor behavior. Electron density theoretical studies have shown that Sn–O bonds were more delocalized than Nb–O ones. The delocalization of the electronic cloud should be explained by the screen effect of internal 3D electrons of the tin atoms.

Compared with the pure BSnNx compounds, the BTSnNxy ceramics exhibit an increase in  $\varepsilon'_{\rm rmax}$  and a decrease in  $T_{\rm m}$  or  $T_{\rm C}$  by addition of Ti<sup>4+</sup> and Sn<sup>4+</sup>, respectively.

The variation in the large chemical composition of these ceramics allows a possible control of their physical properties.

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